

Notice of References Cited

Application/Control No.
09/359,426

Applicant(s)/Patent Under Reexam
Cripps et al.

Examiner
S. Devi, Ph.D.

Art Unit
1645

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N	WO 93/24636	12/09/93	PCT	Hancock et al.	----
O	WO 90/06696	06/28/90	PCT	Seid et al.	----
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U	Sipos et al. Infect. Immun. 59: 3219-3226, 1991, abstract	
V	Nurizzo et al. Structure 5 (9): 1157-1171, 1997, abstract	
W	Kukor et al. J. Bacteriol. 170: 4458-4465, 1988	
X	Brown et al. 177: 6536-6544, 1995	

¹ A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

¹ Dates in MM-YYYY format are publication dates.

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V	Sompolinsky et al. Acta Pathol. Microbiol. Scand. Section B 88: 143-149, 1980	
W	Yamaguchi et al. Jpn. J. Bacteriol. 41: 701-707, 1986	
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V	Barbhaiya et al. FEMS Microbiol. Lett. 51: 169-172, 1988	
W	Meyer et al. Mol. Microbiol. 4: 1401-1405, 1990	
X	Lazar et al. Mol. Cellular Biol. 8: 1247-1252, 1988	

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